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BUTTON CYCLER ENHANCEMENTS FOR ADVANCED INPUT SYSTEMS

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SYSTEM BACKGROUND CURRENT SYSTEM

CAPABILITES

- Incremental counters detect and display # of switch closures after reset
- System force can be somewhat controlled through input pressure.
- Multiple air cylinders (Bimbas) can test multiple keys on a device.

CURRENT SYSTEM DRAWBACKS

- No way to monitor or accurately adjust force applied by pneumatic Bimbas.
- I No way to measure or quantify **switch health**.
- Switch closure count doesn't indicate *when* an error has occurred.





VALUE PROPOSITION

Exhaustive testing of human machine interfaces (HMI) associated with high technology equipment is needed to assure that the HMI remain fully functional throughout the anticipated usage life.

The **goal** of our project is to design a next-generation switch testing equipment/software package that can be easily configured to a broad range of keyboard geometries.

The test will reduce human labor required for data acquisition/visualization and provide information about changes in switch health throughout the entire testing procedure.



SYSTEM REQUIREMENTS

Complete
In Progress
Next Steps

I Priority scale, structured as tiers (1-4)

- 1 LabVIEW program, debounce detection, and datalogging
 - Test 1 to 30 switches simultaneously at a rate from 1Hz to 5Hz – outputs are functional, measurements still need work
 - Allow operator to assign cycle rate, and cycle count prior to test start.
 - Monitor switch health during cycling:
 - Open/Closed resistance waveform
 - Show present values of data logging during test.
 - Switch bounce that lasts >10ms
 - Allow operator to pause/resume/restart tests and save test setups.
 - Format report at test end.

SYSTEM REQUIREMENTS

Complete In Progress Next Steps

- I Priority scale (1-4), structured as tiers (lowest number is highest priority)
 - 2 Force input and detection
 - Allow operator to assign cycle force prior to test start.
 - Monitor maximum applied button force during cycling
 - 3 Switch characterization
 - Characterize switch's F/D/R behavior at pre-programmed test intervals
 - Output hysteresis curve of results
 - 4 Additional hardware redesign
 - Modernize hardware setup for button cycler system with new test apparatus

DEVELOPMENT PROCESS

Snapshot 1 – Arduino Test Apparatus

https://vandalsuidaho-

my.sharepoint.com/:v:/r/personal/over5500_vandals_uidaho_edu/Docum ents/PRESS/Media/Arduino%20Test%20Bench.MOV?csf=1&web=1&e=2n 9FII

Snapshot 2 – Single Cylinder LabVIEW

Apparatus

https://vandalsuidaho-

my.sharepoint.com/:v:/r/personal/over5500_vandals_uidaho_edu/Docum ents/PRESS/Media/LabVIEW%20V0-03.MOV?csf=1&web=1&e=EUJZLp

Snapshot 3 – Multiple Cylinder LabVIEW Apparatus

https://vandalsuidaho-

my.sharepoint.com/:v:/r/personal/over5500_vandals_uidaho_edu/Docum ents/PRESS/Media/LabVIEW%20V0-10.MOV?csf=1&web=1&e=Y83RAW



Snapshot 1 Apparatus

FINAL DESIGN: SYSTEM HARDW/





Key: Solenoid – S Bimba – B

FINAL DESIGN: SYSTEM SOFTWARE

Program structure (overview) – state machine

- Idle
 - User can graphically assign test parameters
 - Natural state of the program when nothing is happening
- Calibrating
 - Data on the system is obtained that is needed prior to the test
- Testing
 - Information on switch health is recorded and displayed to the user
- Logging
 - A brief system pause is allowed to log data to the device
- Paused
 - So the operator can make adjustments to hardware if needed during the test
- Complete
 - The test reached its specified number of cycles and is now finished
 - Analysis can be executed

AIS Button Cycler V0-10

	Program State										Completion (%)
	1) Select test set	tings									
	Configuration	I	Test Parameters								
1	Test Config CSV	File Path	Test Duration (Cycles) 100					CLEAR ALL			
	C:\Users\aover	by\Desktop\AIS Capstone	AlS Button Cycler U of I	Cycle Rate (Hz) 5				RECALL			
F				Failure Criteria (%) 2					RECALL		
	Analyzation			Data Logging Period (Cycles) 10							
	Data Logging Fo	older Path	Closed Resistance Threshold (Ohms) 40								
				Closure Debounce Threshold (ms)							
Set	Data Logging Fi	le Name (no extension ne	Open Resistance Threshold (Ohms) 100								
1						Release Debounce T	hreshold (ms)	10			
ī											
(2) Choose cylind	ders/buttons to test									
	CLEAR ALL	Cylinder ID	Switch ID	Cylinder Output Channel	Total Failures	Avg. Closed Resistance (Ohms)	Avg. Closure Debounce (ms)		Avg. Open Resistance (Ohms)	Avg. Rel Deboun	ease ce (ms)
F		1									
		2									
¢		3									
		4									
		5									
		6									
d,		7									
		8									
		9									
		10							1		

CLOSE VI

SYSTEM SOFTWARE – MULTIPLE CYLINDERS

- State control through a Boolean array
- Indexer to keep track of what cylinder will fire
- Timer to tell the cylinder when it needs to extend or retract



TEST ANALYSIS

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Capabilities

- Provide a general oversight of the data captured by the LabVIEW Program
- Provide an easy to analyze Data Presentation Format



TEST ANALYSIS - SUMMARY PAGE

4	Ä	В	C	D	E	E I	G	Н	l Î	J	К	L	
1				Test Summ	ary								
2													
3		Test ID		Test_00	Ir	nport CSVs		ylinder ID	1	C	ylinder ID	2	
4		Total Cycles		1000		li i	Switch		A		Switch ID	E	
5		Cycle Rate		5 Hz	N	1ake Charts		Cycle #	Fail Type		Cycle #	Fail Type	
6		Active Cy	linders	4		1		21	CL_DB		21	CL_DB	
7					Failure Logs			26	CL_DB		26	CL_DB	
8						A 78		27	CL_DB		27	CL_DB	
9								30	CL_DB		30	CL_DB	
10	Cylinder ID	Switch ID	Failures	Closed Resistance	Closure Debounce	ounce Open Resistance		38	CL_DB		38	CL_DB	
11	1	А	80	0	80	0		39	CL_DB		39	CL_DB	
12	2	E	80	0	80	0		41	CL_DB		41	CL_DB	
13	3	В	80	0	80	0		42	CL_DB		42	CL_DB	
14	4	;	80	0	80	0		43	CL_DB		43	CL_DB	
15								44	CL_DB		44	CL_DB	
16								45	CL_DB		45	CL_DB	
17								47	CL_DB		47	CL_DB	
18								48	CL_DB		48	CL_DB	
19								49	CL_DB		49	CL_DB	
20								51	CL_DB		51	CL_DB	

LESSONS LEARNED

I ARRAY INDICES

Handling the immense amount of data is difficult, and we ran in to problems with our auto-indexing algorithm that still need to be debugged

I DATA CLUSTERS

A great way to handle data – we would have started here if we knew about them during the start of the project

I MULTIPLE BIMBA SYSTEM

Projects don't always scale as easily as expected.

I DATA EXPORTING AND ANALYSIS

Understand what is needed as a basis early on.

NEXT STEPS

- Priority scale (1-4), structured as tiers (lowest number is highest priority)
 - 1 Achieve proper measurement inputs and datalogging capabilities for a multiple switch system
 - 2 Force input and detection
 - Allow operator to assign cycle force prior to test start.
 - Monitor maximum applied button force during cycling
 - 3 Switch characterization
 - Characterize switch's F/D/R behavior at pre-programmed test intervals
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QUESTIONS?



Chris is seeking a position in software development or data processing to gain experience for running his own business.



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Andrew is working in the 3D printing & composites industry specifically geared towards automated manufacturing processes for aerospace



Cody is working in the infrastructure division utilizing his background in construction and engineering.